

**P-Channel MOSFET** 

## **General Description**

The WSK50P10 is the highest performance Trench P-Channel MOSFET with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSK50P10 meet the RoHS and Green Product requirement, 100%  $E_{AS}$  guaranteed with full function reliability approved.

#### **Features**

- 100% UIS + R<sub>g</sub> Tested.
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

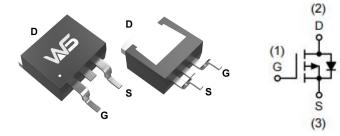
## **Product Summery**

BV <sub>DSS</sub>	$R_{DS(ON)}$	I <sub>D</sub>
-100V	40mΩ	-50A

## **Applications**

- Power Management for Industrial DC/DC Converters
- Load switch
- Battery protection

### **TO-263-2L Pin Configuration**



## **Absolute Maximum Ratings** (T<sub>A</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter		Rating	Units
V <sub>DS</sub>	Drain-Source Voltage		-100	V
V <sub>GS</sub>	Gate-Source Voltage			\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \
I <sub>D</sub> <sup>7</sup>	Continuous Drain Current	T <sub>C</sub> =25°C	-50	
ID.	Continuous Drain Current	T <sub>C</sub> =100°C	-30	A
I <sub>DM</sub> <sup>3</sup>	Pulse Drain Current		-150	
P <sub>D</sub> <sup>2</sup>	Power Dissipation	T <sub>C</sub> =25°C	140	W
I <sub>AS</sub> <sup>3</sup>	Single pulse Avalanche Current		-35	А
E <sub>AS</sub> <sup>3</sup>	Single pulse Avalanche Energy	L=0.3mH	87	mJ
T <sub>STG</sub>	Storage Temperature Range		-55 to 150	· °C
TJ	Operating Junction Temperature Range		-55 to 150	
D 14	Thermal Desistance Junation to Ambient	t≤10s	20	
R <sub>θJA</sub> <sup>1,4</sup>	Thermal Resistance-Junction to Ambient	Steady State	62	°C/W
$R_{ heta JC}$	Thermal Resistance-Junction to Case		1.1	



**P-Channel MOSFET** 

### Electrical Characteristics (T<sub>J</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =-250μA	-100			V
P	Static Drain-Source On-Resistance	V <sub>GS</sub> =-10V , I <sub>D</sub> =-20A		40	52	mΩ
R <sub>DS(ON)</sub>	Static Dialii-Source Off-Resistance	V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-20A		44	62	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}$ = $V_{DS}$ , $I_{D}$ =-250 $\mu$ A	-1.0	-1.6	-2.5	V
I <sub>DSS</sub>	Drain-Source Leakage Current	$V_{DS}$ =-100V , $V_{GS}$ =0V			-1.0	μA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{DS}$ =0V , $V_{GS}$ =±20V			±100	nA
$Q_g$	Total Gate Charge (10V)			41		
$Q_{gs}$	Gate-Source Charge	$V_{DS}$ =-50V , $V_{GS}$ =-10V , $I_{D}$ =-5A		8		nC
$Q_{gd}$	Gate-Drain Charge			9		
T <sub>d(on)</sub>	Turn-On Delay Time			14		
T <sub>r</sub>	Rise Time	$V_{DS}$ =-50V , $V_{GS}$ =-10V , $I_{D}$ =-5A		40		
T <sub>d(off)</sub>	Turn-Off Delay Time	$R_L=1\Omega$ , $R_{GEN}=6\Omega$		101		ns
T <sub>f</sub>	Fall Time	32.1		106		
C <sub>iss</sub>	Input Capacitance			2130		
C <sub>oss</sub>	Output Capacitance	$V_{DS}$ =-50V , $V_{GS}$ =0V , $f$ =1.0MHz		195		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			15		

#### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
Is 7	Continuous Source Current				-50	Α
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =-1A		-0.7	-1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> =-20A , di/dt=500A/μs		104		ns
Q <sub>rr</sub>	Reverse Recovery Charge	1520A ; di/dt-300A/µS		280		nC

#### Note:

- The value of R<sub>BJA</sub> is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>BJA</sub> t≤ 10s and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- 2. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- 3. Single pulse width limited by junction temperature  $T_{J(MAX)}$ =150°C.
- 4. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
- 5. The static characteristics in Figures 1 to 6 are obtained using <300 $\mu$ s pulses, duty cycle 0.5% max.
- 6. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =150°C. The SOA curve provides a single pulse rating.
- 7. The maximum current rating is package limited.
- 8. These tests are performed with the device mounted on 1 in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$ =25°C.
- 9. The maximum current rating is silicon limited





## **Typical Characteristics**

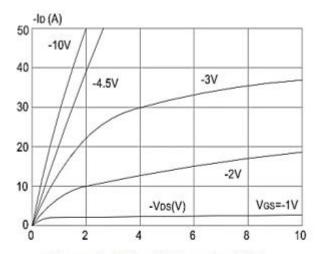


Figure 1: Output Characteristics

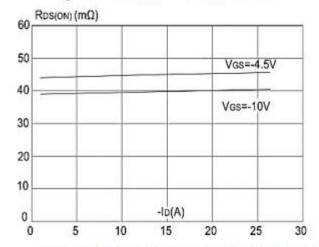


Figure 3:On-resistance vs. Drain Current

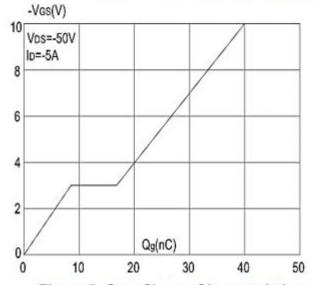


Figure 5: Gate Charge Characteristics

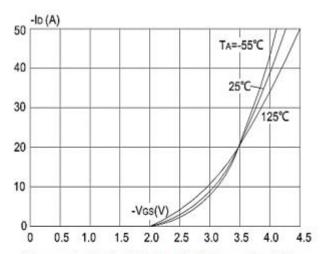


Figure 2: Typical Transfer Characteristics

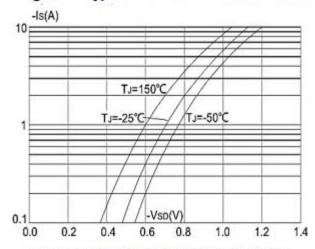


Figure 4: Body Diode Characteristics

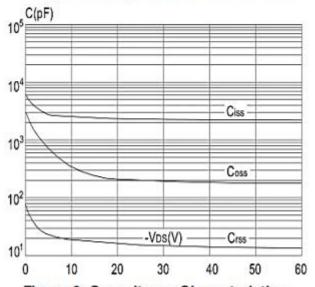


Figure 6: Capacitance Characteristics



## **Typical Characteristics (Cont.)**

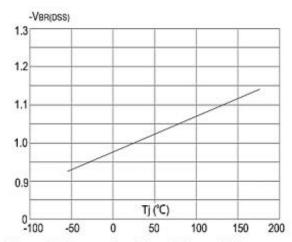


Figure 7: Normalized Breakdown Voltage vs Junction Temperature

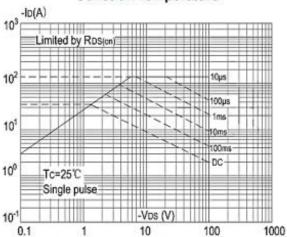


Figure 9: Maximum Safe Operating Area

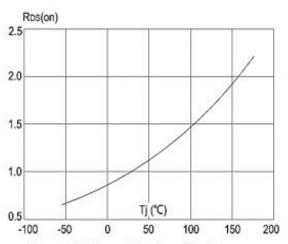


Figure 8: Normalized on Resistance vs.

Junction Temperature

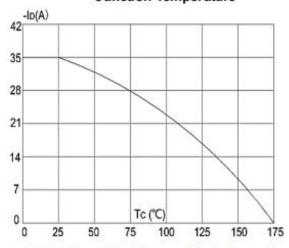


Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

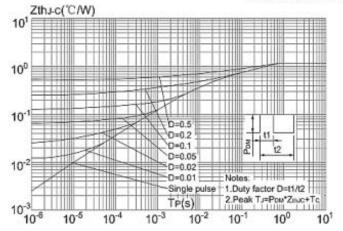
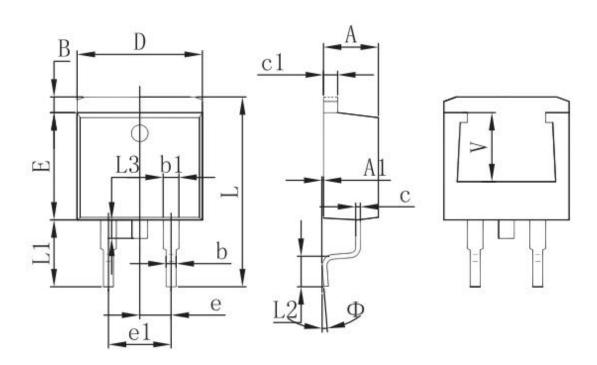


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Ambien



# **Packaging information**



Combal	Dimensions Ir	Millimeters	Dimensions Ir	n Inches
Symbol	Min.	Max.	Min.	Max.
Α	4.470	4.670	0.176	0.184
A1	0.000	0.150	0.000	0.006
В	1.120	1.420	0.044	0.056
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
С	0.310	0.530	0.012	0.021
c1	1.170	1.370	0.046	0.054
D	10.010	10.310	0.394	0.406
E	8.500	8.900	0.335	0.350
е	2.540	TYP.	0.100	TYP.
e1	4.980	5.180	0.196	0.204
L	14.940	15.500	0.588	0.610
L1	4.950	5.450	0.195	0.215
L2	2.340	2.740	0.092	0.108
L3	1.300	1.700	0.051	0.067
Ф	0°	8°	0°	8°
V	5.600	REF.	0.220	REF.





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